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Renesas Technology Corp.
Customer Support Dept.
April 1, 2003

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Keep safety first in your circuit designs!

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Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.

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4AK27

Silicon N Channel MOS FET
High Speed Power Switching

RENESAS

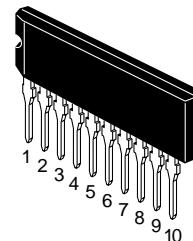
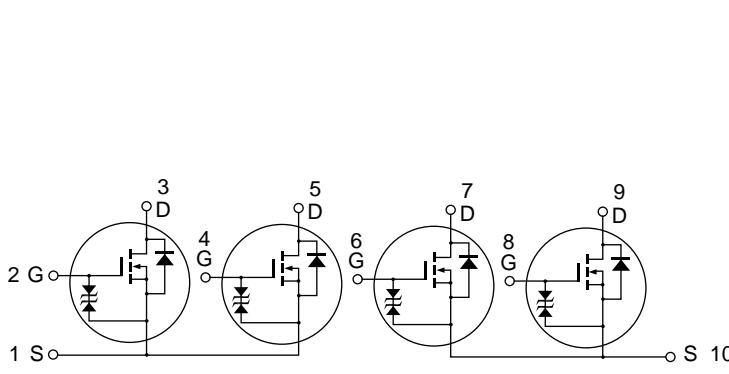
ADE-208-728 (Z)
1st. Edition
Mar. 2001

Features

- Low on-resistance
 $R_{DS(on)} \leq 0.15\Omega$, $V_{GS} = 10V$, $I_D = 3.0A$
- 4V gate drive devices.
- High density mounting

Outline

SP-10



1, 10. *Source*
2, 4, 6, 8. *Gate*
3, 5, 7, 9. *Drain*

Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Ratings | Unit |
|----------------------------------------|----------------------------------------|-------------|------|
| Drain to source voltage | V _{DSS} | 60 | V |
| Gate to source voltage | V _{GSS} | ±20 | V |
| Drain current | I _D | 5 | A |
| Drain peak current | I _{D(pulse)} ^{Note1} | 20 | A |
| Body-drain diode reverse drain current | I _{DR} | 5 | A |
| Avalanche current | I _{AP} | 5 | A |
| Avalanche energy1 | E _{AR} | 2.1 | mJ |
| Channel dissipation | Pch(Tc=25°C) ^{Note2} | 28 | W |
| Channel dissipation | Pch ^{Note2} | 4 | W |
| Channel temperature | Tch | 150 | °C |
| Storage temperature | Tstg | −55 to +150 | °C |

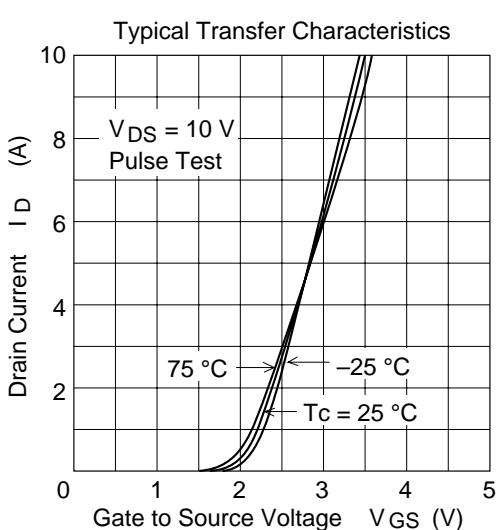
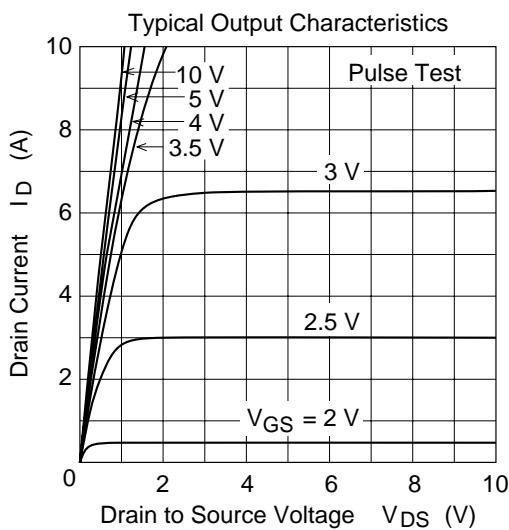
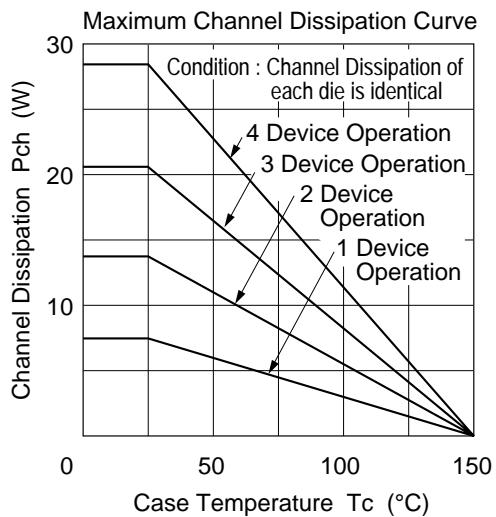
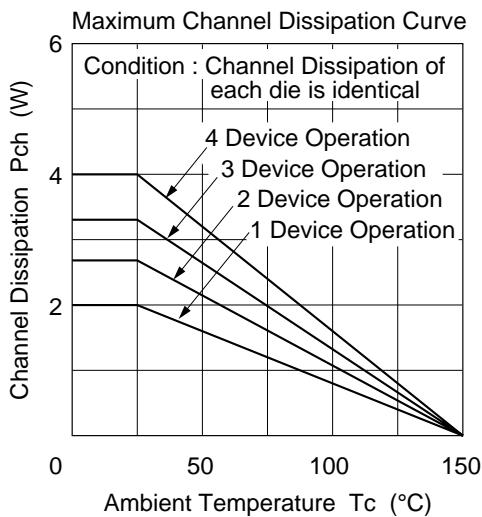
Note: 1. PW ≤ 10μs, duty cycle ≤ 1 %
 2. 4 devices poeration
 3. Value at Tch=25°C, R_g ≥ 50Ω

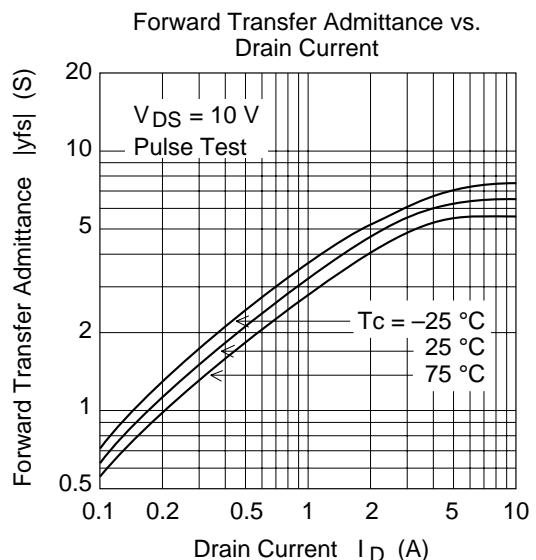
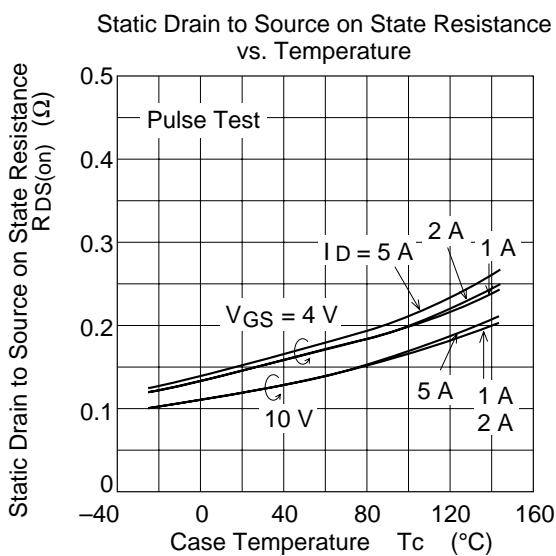
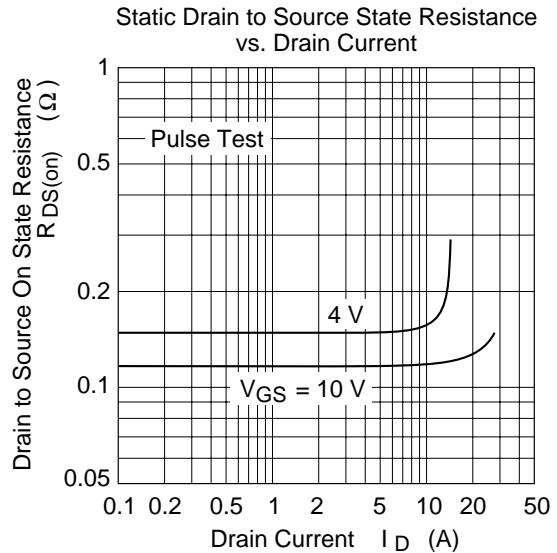
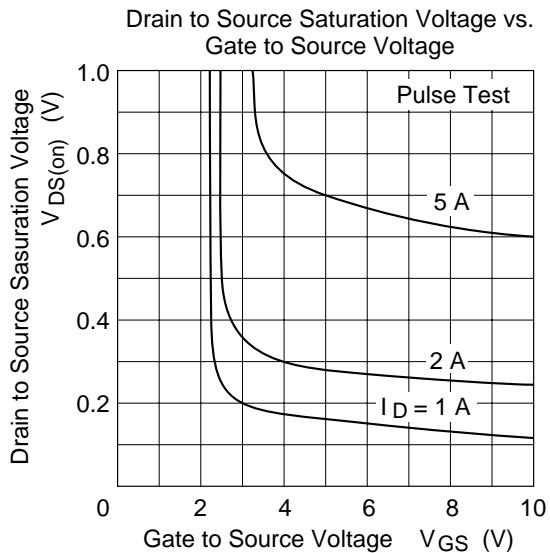
Electrical Characteristics (Ta = 25°C)

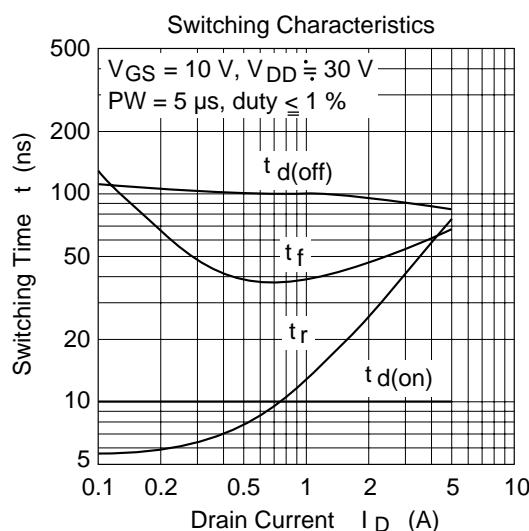
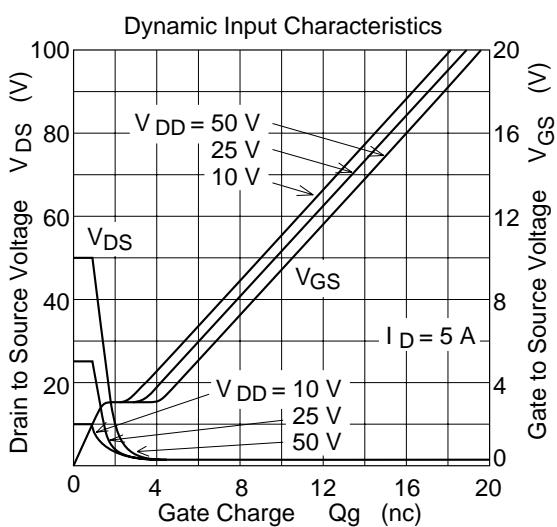
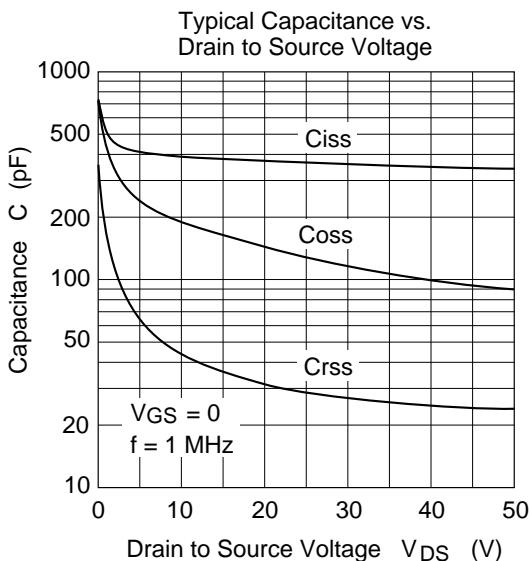
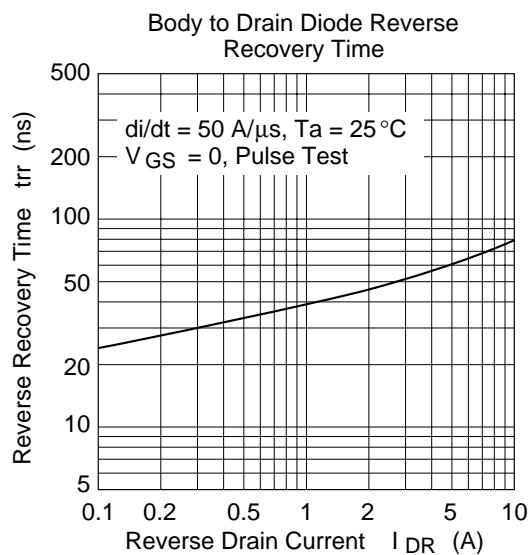
| Item | Symbol | Min | Typ | Max | Unit | Test Conditions |
|--------------------------------------------|----------------------|-----|------|------|------|----------------------------------------------------------------|
| Drain to source breakdown voltage | V _{(BR)DSS} | 60 | — | — | V | I _D = 10mA, V _{GS} = 0 |
| Gate to source breakdown voltage | V _{(BR)GSS} | ±20 | — | — | V | I _G = ±100μA, V _{DS} = 0 |
| Zero gate voltage drain current | I _{DSS} | — | — | 100 | μA | V _{DS} = 50 V, V _{GS} = 0 |
| Gate to source leak current | I _{GSS} | — | — | ±10 | μA | V _{GS} = ±16V, V _{DS} = 0 |
| Gate to source cutoff voltage | V _{GS(off)} | 1.0 | — | 2.25 | V | I _D = 1mA, V _{DS} = 10V |
| Static drain to source on state resistance | R _{DS(on)} | — | 0.12 | 0.15 | Ω | I _D = 3A, V _{GS} = 10V ^{Note4} |
| Static drain to source on state resistance | R _{DS(on)} | — | 0.15 | 0.2 | Ω | I _D = 3A, V _{GS} = 4V ^{Note4} |
| Forward transfer admittance | y _{fs} | 3.0 | 5.5 | — | S | I _D = 3A, V _{DS} = 10V ^{Note4} |
| Input capacitance | C _{iss} | — | 390 | — | pF | V _{DS} = 10V |
| Output capacitance | C _{oss} | — | 190 | — | pF | V _{GS} = 0 |
| Reverse transfer capacitance | C _{rss} | — | 45 | — | pF | f = 1MHz |
| Turn-on delay time | t _{d(on)} | — | 10 | — | ns | V _{GS} = 10V, I _D = 3A |
| Rise time | t _r | — | 42 | — | ns | R _L = 10Ω |
| Turn-off delay time | t _{d(off)} | — | 90 | — | ns | |
| Fall time | t _f | — | 55 | — | ns | |
| Body-drain diode forward voltage | V _{DF} | — | 1.0 | — | V | I _F = 5A, V _{GS} = 0 |
| Body-drain diode reverse recovery time | t _{rr} | — | 60 | — | ns | I _F = 5A, V _{GS} = 0 dI/F / dt = 50A/μs |

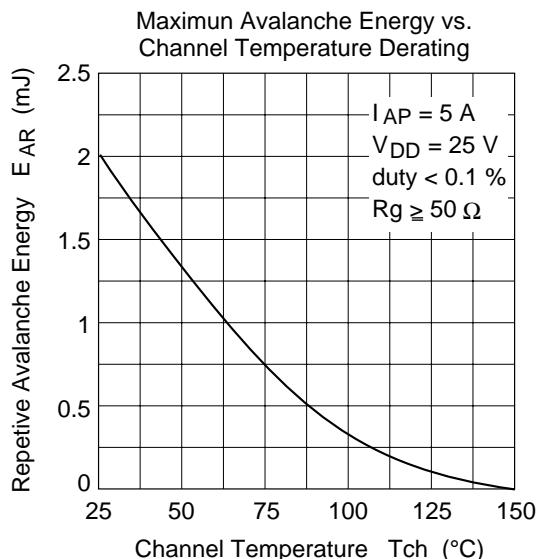
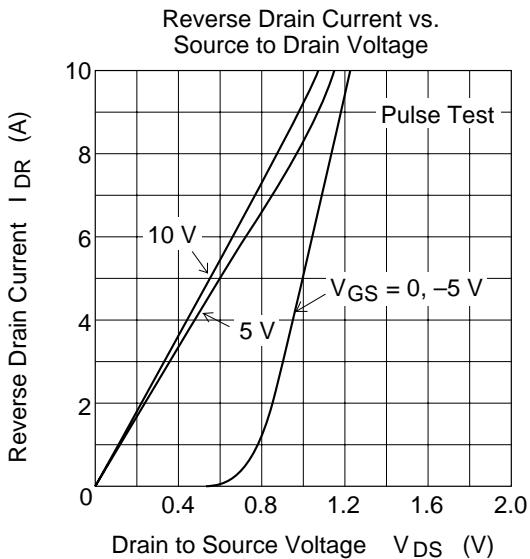
Note: 4. Pulse test

Main Characteristics

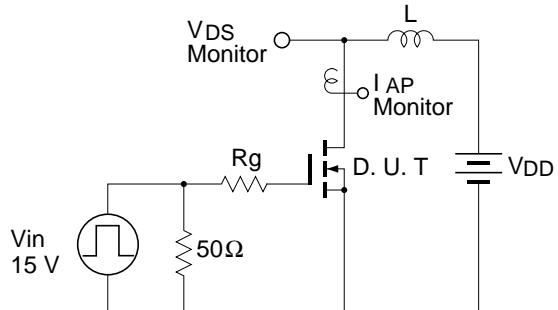




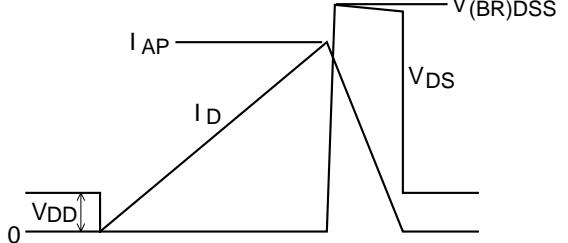




Avalanche Test Circuit and Waveform



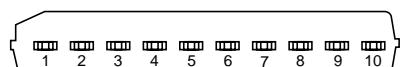
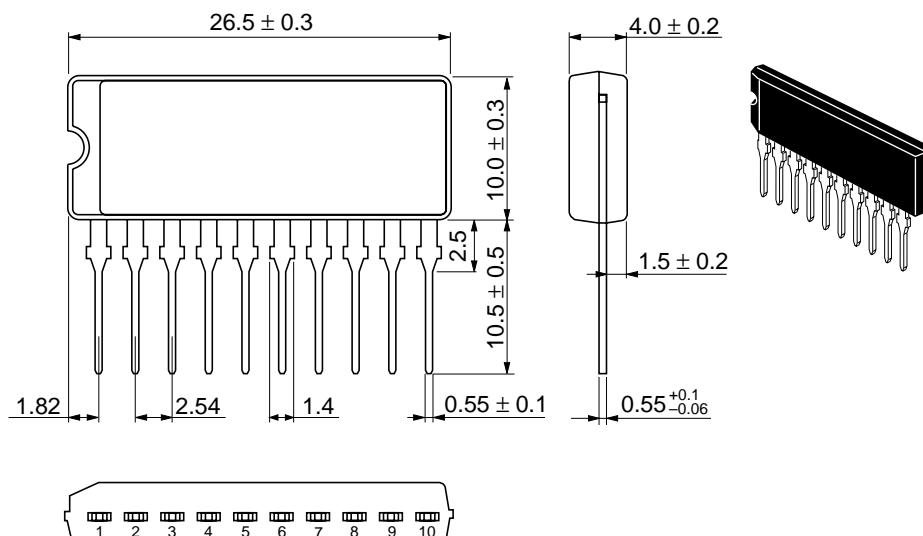
$$E_{AR} = \frac{1}{2} \cdot L \cdot I_{AP}^2 \cdot \frac{V_{DSS}}{V_{DSS} - V_{DD}}$$



Package Dimensions

As of January, 2001

Unit: mm



| | |
|------------------------|-------|
| Hitachi Code | SP-10 |
| JEDEC | — |
| EIAJ | — |
| Mass (reference value) | 2.9 g |

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